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Interlayer vacancy characterization of synthetic phlogopitic micas by IR spectroscopy

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Abstract: Phlogopitic micas of the solid solution binaries $KMg_3[AlSi_3O_{10}](OH)_2$ (phlogopite) – $RbMg_3[AlSi_3O_{10}](OH)_2$ (Rbphlogopite), phlogopite – $CsMg_3[AlSi_3O_{10}](OH)_2$ (Cs-phlogopite), and phlogopite – $BaMg_3[Al_2Si_2O_{10}](OH)_2$ (kinoshitalite) have been synthesized at temperatures of 700 and 800°C and pressures of 0.2 and 2.0 GPa. The run products have been investigated by optical microscopy, X-ray powder diffraction, electron microprobe, and infrared spectroscopy. All runs yielded between 81 and 100 wt.% of phlogopitic micas, beside traces of quartz, sanidine, and in one run talc. Celsian and cymrite formed as additional phases in the runs of the (K-Ba)-series. The synthetic phlogopitic micas often consist of mixtures of the three polytypes 1M, $2M_1$ and $2M_2$, with 1M being the most abundant polytype. Based on electron microprobe analyses, interlayer vacancy concentrations of up to 0.29 (p.f.u.) were determined, indicating a significant talc component within the synthesized phlogopitic micas with incompletely filled interlayer sites exhibit a further OH-band, centered in the spectral range 3674 - 3678 cm⁻¹. The intensity of this band is correlated with the amount of vacancies. The vacancy concentration of phlogopitic micas was determined quantitatively from the intensity of this infrared band by using the intensity of the principal OH-band of synthetic talc ($Mg_3[Si_4O_{10}](OH)_2$) as a standard. The vacancy concentration of the interlayer site as determined in such a way by infrared spectroscopy corresponds to those independently derived by electron microprobe analyses.

Key-words: phlogopitic micas, interlayer vacancies, IR spectroscopy.

Introduction

Phlogopitic micas have been extensively investigated by numerous authors using infrared (IR) spectroscopy (e.g., Vedder, 1964; Farmer, 1974; Tateyama et al., 1976; Velde, 1983; Robert & Kodama, 1988). The various absorption bands in the OH-stretching vibrational region (3200 - 3800 cm⁻¹) are attributed to the specific atomic groupening at the octahedral, tetrahedral, and interlayer sites around the OHsites. The principal and strongest OH-stretching frequency of phlogopite lies at about 3724 cm⁻¹. This band is called N-(normal) frequency after Vedder (1964) and represents hydroxyls, for which the neighboring octahedral sites are filled with divalent ions. For phlogopite, the ideal local octahedral coordination around a hydroxyl group leading to the N-band is (MgMgMg)^{VI}. The position of the N-band can slightly vary with the substitutions in the twelve-fold interlayer position and in the octahedral and tetrahedral sheets. In principle, the N-band of natural phlogopitic micas is rather broad (full widths at half maximum (FWHM) of about 25 cm⁻¹) representing the structural pertubations associated with the various interlayer, octahedral and tetrahedral substitutions (Farmer, 1974). According to e.g., Robert & Kodama

(1988), OH-stetching bands lying in the frequency-range 3630 - 3675 cm⁻¹ are attributed to Al³⁺-incorporation in the octahedral sheets replacing divalent cations. Generally, OHvibrations resulting from the substitution of divalent ions by trivalent ions in the octahedral sites plus the additional processes required for neutrality (e.g., Al^{IV} for Si^{IV}) are named I- (impurity) bands after Vedder (1964). The local octahedral coordination can be described as (MgAlMg)^{VI}. The OH-stretching band system in the low-energy spectral range 3450 - 3620 cm⁻¹ is assigned to vacancies in the octahedral sheet (\Box^{VI}) , and are named V- (vacancy) bands after Vedder (1964). Processes required for neutrality are the substitution of two divalent ions in the octahedral sites by Al³⁺ leading to $(Al\Box Al)^{VI}$ as the local octahedral cation coordination around the hydroxyl group. For dioctahedral micas, Bresson & Drits (1997) showed that twelve-fold vacancies (\Box^{XII}), which can be described as pyrophyllite-like local structural environments, cause an additional OH-band at about 3675 cm⁻¹. The energy of this band is in correspondance to the principal OH-stretching frequency of pyrophyllite. In analogy to dioctahedral micas, interlayer vacancies within phlogopitic micas can be chemically described as a talc component. Robert et al. (1983) observed for trioctahedral Li-micas an OH-frequency at 3678 cm⁻¹, which they attributed to vacant alkaline sites. In NH₄-phlogopite, Harlov *et al.* (2001) assigned an OH-stretching band at about 3675 cm⁻¹ to hydroxyls located in the vicinity of vacant interlayer sites. With the exception of these two studies, the influence of \Box^{XII} on the IR spectra of trioctahedral phlogopitic micas has not been considered up to now.

The present study was initiated by our recent investigations on synthetic (K,Rb,Cs)-phlogopitic micas (Melzer & Wunder, 2001), for which significant amounts of interlayer vacancies (up to 25 mole %) were determined by electron microprobe (EMP) analyses. However, the amount of interlayer vacancies was rather ambiguous due to a possible alkali-loss during EMP measurements. Therefore, aimed to find an accurate method for the characterization of the talc component within phlogopitic micas, in the present study we investigated a suite of well-defined synthetic (Cs, K, Rb, Ba)-phlogopites, exhibiting varying amounts of incompletely filled interlayer sites. We show that the OH-stretching band observed in the spectral range 3674 - 3678 cm⁻¹ of the synthetic samples by IR spectroscopy is due to the vacant interlayer site within phlogopite and that the intensity of this IR band can be correlated with the amount of the talc component, which was independently determined by EMP.

Experimental and analytical methods

Experimental methods

The runs are divided into three series. The first series is the $KMg_3[AlSi_3O_{10}](OH)_2$ (phlogopite) – $RbMg_3[Al-Si_3O_{10}](OH)_2$ (Rb-phlogopite) series (K-Rb), the second one the phlogopite – $CsMg_3[AlSi_3O_{10}](OH)_2$ (Cs-phlogopite) series (K-Cs), and the third one the phlogopite – $BaMg_3[Al_2Si_2O_{10}](OH)_2$ (kinoshitalite) series (K-Ba). Run conditions were 800°C at 0.2 and 2.0 GPa; some synthesis experiments of the (K-Rb)-series were also performed at 700°C and 0.2 GPa. The run conditions of each experiment are summarized in Table 1.

For synthesis experiments at 0.2 GPa, standard cold-seal hydrothermal vessels were used. The temperature in the hydrothermal experiments was controlled internally by Ni-CrNi thermocouples next to the sample position. The uncertainty of the temperature is ±5°C. The pressure was measured with a calibrated strain-gauge. Pressure uncertainty of each run was less than 5 MPa. Runs lasted 10 to 14 days. The experiments were quenched by cooling the autoclaves with compressed air to less than 300°C in 3 minutes. High-pressure experiments at 2.0 GPa were conducted in a non-endloaded piston-cylinder apparatus using NaCl-graphite-assemblies. Temperatures were measured using Ni-CrNi thermocouples with an accuracy of ±10°C. Pressure was calibrated using the equilibrium albite = jadeite + α -quartz. Uncertainties in pressure are approximately ± 2 %. Runs lasted 5 to 7 days. The samples were quenched to 200°C in less than 15 seconds.

Mixtures of oxides of stoichiometric phlogopite composition with an excess of 5 wt.% SiO_2 were used as solid starting materials. The starting fluid was a 2 molal aqueous chloridic solution bearing either (K,Rb) for the first, (K,Cs) for the second, or (K,Ba) for the third series. Starting bulk compositions for the three series were chosen, such that solid solutions along the joins phlogopite – Rb-phlogopite, phlogopite – Cs-phlogopite and phlogopite – kinoshitalite were expected. The fluid/solid ratio was ≥ 2 for all syntheses experiments. Au-capsules of 25 mm length, 3 mm in diameter and wall-thickness of 0.3 mm for the experiments at 0.2 GPa and Pt-capsules of 10 mm length, 3 mm in diameter and 0.3 mm wall-thickness for the experiments at 2.0 GPa were used. The filled capsules were sealed using a plasma welder while cooled with an ice/water mixture. Further details of the experimental procedure for the synthesis of phlogopite of the (K,Rb)- and (K,Cs)-series have been described by Melzer & Wunder (2001).

Analytical methods

Solid phases were characterized by optical microscopy, powder X-ray diffraction (XRD), EMP analyses and IR spectroscopy. Details of these methods are already described by Gottschalk & Andrut (1998) and are therefore only briefly documented herein.

XRD patterns were recorded in transmission using a fully automated STOE STADI P diffractometer (Cu $K\alpha_1$ -radiation), equipped with a primary monochromator. Operating conditions were 40 kV and 40 mA. The spectra were recorded in the range of 5 to 125 °20 using a step interval of 0.1°. The resolution of the PSD was set to 0.02°. Counting times were selected to yield a maximum intensity of 2000 to 3000 counts for each sample, resulting in 5 to 20 s per detector step. The unit cell and other structural parameters were refined using the *GSAS* software package for Rietveld refinement (Larson & Von Dreele, 1987). As initial structure models for the refinement of the various phlogopite polytypes, the structural parameter of Rayner (1974) for the *1M*-polytype, Bohlen *et al.* (1980) for the 2*M*₁-polytype, and Sartori *et al.* (1973) for the 2*M*₂-polytype were used.

EMP analyses were conducted with Cameca SX50 and SX100 microprobes equipped with wave-length dispersive systems and applyed PAP-correction (Pouchou & Pichoir, 1984). Operating conditions were 15 kV and 20 nA. Counting times for all elements were 20 s for the peak position and 10 s for the background. Well defined natural minerals were used as standards: for Si (wollastonite), for Mg (tremolite) and for K and Al (orthoclase). For Rb, Cs and Ba analyses, well characterized synthetic minerals were used. Rb was standardized on Rb-feldspar (RbAlSi₃O₈), Cs on pollucite (CsAlSi₂O₆) and Ba on celsian (BaAl₂Si₂O₈). EMP analyses of phlogopite were accepted if oxide sums were larger than 90 wt.%, except of run SM20-99 (see Table 2), where totals of about 89 – 90 wt.% were available.

For the IR absorption measurements, samples were prepared by grinding 1 mg of the run product and dispersing it into 450 mg of KBr. The homogenized mixtures were coldpressed under vacuum to transparent pellets. Before recording the spectra, the pellets were dried at 170°C for 48 hours. IR absorption spectra were collected in the spectral range of 3400 to 3800 cm⁻¹ with a resolution of 0.25 cm⁻¹ using a

Table 1. Details of Rietveld refinement and derived phase proportions.

run No.	SM	SM	SM	SM	SM	SM	SN	1 S	М	SM	SM	SM	SM	SM	SM
	7-98	9-98	10-98	11-98	12-98	35-98	36-9	98 37	-98	45-98	46-98	65-98	27-99	30-99	38-99
temperature [°C]	800	800	800	800	800	800	80	0 8	00	800	800	700	700	700	800
pressure [MPa]	200	200	200	200	200	2000	200	1 0	00	2000	2000	200	200	200	200
$X_{\rm K}$ (mica, see Table 2)	0.31	0.70	0.73	0.36	0.72	0.05 (K D	0.5 n (di	1 U.	.00 site e	0.33	0.24	0.48	0.71	0.65	0.25
riperintental series (IX-IXB)-philogophic series															
	702	(10	40.0	700	455	(50	(5	0 7	0.7	(())	054	076	50.4	50.4	520
integrat.time/step interval [s]	/93	610	488	/80	455	650	65	0 3	85	660	854	9/6	594 2429	594 2011	528
max. counts/step	3268	2347	2640	3113	2887	3152	300	09 20 19 20)49 :46	2/09	3130	2/96	3428	3011	2820
unique reflections	3508	2401	2443	2323	14/5	2400	240	08 20	040 72	2403	2454	2373	3104	3211	55/5
structural parameters	13	70	27	70 26	20	79 20	20		' 3 7	18	70	15	03	15	54 26
N D	22 5907	24 5000	27 5804	20 5706	23 5247	20 5940	20 504) 4 11 50	27	23 5907	29 5942	20	20	20	20
N-P D	3897	3898	3894	5/90	0.092	3849	394	1 JC	98 960	3891	3843	3847	3839	3847	3918
R	0.008	0.081	0.085	0.055	0.085	0.002	0.00	08 U.U	202	0.003	0.057	0.047	0.055	0.059	0.005
Rwp	0.091	0.107	0.112	0.073	0.108	0.085	0.05	91 U.U 0 1	J93 07	0.084	0.075	0.062	0.075	0.078	0.087
χ2 d statistics (Deathin Wetcom)	1.78	1.59	1.00	1.62	1./3	1.02	1.8	2 1.	8/	1.40	1.50	1.25	1.21	1.42	1.24
d statistics (Durbin-watson)	1.13	1.30	1.24	1.19	1.19	1.19	1.1	0 1.	07	1.40	1.25	1.55	1.62	1.41	1.65
results of quantitative phase anal	lyses [wt.	%/100]													
1M phlogopite	0.69	0.65	0.57	0.67	0.83	0.69	0.4	7 0.	42	0.62	0.62	0.77	0.65	0.57	0.58
2M ₁ phlogopite	0.21	0.25	0.32	0.19	0.17	0.22	0.3	3 0.	34	0.31	0.28	0.18	0.21	0.26	0.18
2M ₂ phlogopite	0.09	0.10	0.11	0.13	-	0.09	0.2	0 0.	24	0.07	0.10	0.05	0.08	0.07	0.05
quartz	-	-	-	0.01	-	-	-		-	-	-	-	-	-	-
sanidine	0.01	-	-	-	-	-	-		-	-	-	-	0.06	0.10	0.19
Table 1. (cont.)															
run No.	SM	SM	SM	SM	SM	[S]	М	SM	S	М	SM	SM	SM	SM	SM
	56-98	61-98	63-98	19-99	9 20-9	9 21.	.99	47-99	5-	98	3-99	4-99	83-99	84-99	86-99
temperature [°C]	800	800	800	800	800) 80	00	800	8	00	800	800	800	800	800
pressure [MPa]	200	2000	2000	200	200) 20	00	200	20	00	200	200	2000	2000	200
X_{ν} (mica, see Table 2)	0.00	0.80	0.59	0.80	0.79) 0.	69	0.82	0.	01 (0.70	0.83	0.73	0.80	0.74
experimental series			(K-Cs)	-phlogo	pite se	ries					(K-Ba)-phlog	gopite se	eries	
refinement details				1 0	•								, 1		
integrat time/step interval [s]	1080	703	703	702	660	5/	10	300	6	50	578	427	188	427	600
max_counts/step	2/35	2008	2006	3212	322	8 76	+0 //	3376	33	60 7	045	+∠/ 2066	400 2747	3081	2820
unique reflections	2433	2908	2300	1/180	323	0 20 0 14	02	1/82	24	71 2	2943	2900	5407	2/30	2020
structural peremeters	2000	2438 52	2390	1400	20	2 14	92 1	40	24	0	19 19	2433	57	2439	5955
structural parameters	27	52 26	20	20	29	3 2	4	49	4	0	40 24	24	25	32 22	26
	5360	5870	5880	5807	20 7 580	2 50	2 91	5212	59	270 5	2 4 876	24 58/8	23 5866	23 5803	20 5866
D	0.048	0.055	0.060	0.05	200	5 00	51	0.070	0.0)64 0	065	0.070	0.061	0.063	0.062
Λ D	0.040	0.055	0.000	0.052	2 0.03	$\frac{3}{2}$ 0.0	101 160	0.079	0.0	104 U	.005	0.070	0.001	0.005	0.002
K _{wp}	1.005	1 25	1 56	1.24	1 3	$\frac{5}{1}$	709 71	1 50	1	0^{-10}	1 3 8	1.62	1.46	1 44	1 55
λ^2	1.90	1.23	1.50	1.24	1.52	2 1.	50	1.50	1.	92 ·	1.56	1.02	1.40	1.44	1.33
d statistics (Durbin-watson)	1.01	1.39	1.20	1.02	1.40	5 1.	39	1.41	1.	02	1.45	1.10	1.37	1.55	1.32
results of quantitative phase anal	lyses [wt.	%/100]													
1M phlogopite	0.50	0.82	0.67	0.83	0.87	/ 0.'	/8	0.88	0.	29 (0.82	0.56	0.55	0.75	0.78
2M ₁ phlogopite	0.27	0.14	0.31	0.17	0.07	(0.1	22	0.12	0.	54 (J.17	0.34	0.34	0.21	0.12
2M ₂ phlogopite	0.23	0.04	-	-	0.02	<u> </u>	-	-	0.	17 ().01	0.10	0.02	0.04	0.01
quartz	-	-	-	-	0.04	+ •	-	-		-	-	-	-	-	-
celsian	-	-	-	-	-	-	-	-		-	-	-	-	-	0.09
cymrite	-	-	-	-	-	-	-	-		-	-	-	0.09	-	-
talc	-	-	0.02	-	-		-	-		-	-	-	-	-	-

Bruker IFS 66v FTIR spectrometer equipped with a globar light source, a KBr-beam splitter and a DTGS-detector. Spectra were averaged over 256 scans. After linear background correction, the absorption band center, FWHM, and integral intensities were determined using the program *PeakFit* by JANDEL SCIENTIFIC.

Results

Optical investigations

The synthetic phlogopitic micas of the three experimental series generally occur as hexagonal platelets with diameters

run No.	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM
1	7-98	9-98	10-98	11-98	12-98	35-98	36-98	37-98	45-98	46-98	65-98	27-99	30-99	38-99
anaryses	13	3	Z	3	9	9 (12 Dh	0) == h la == a		3	17	/	Z	/	2
exp. series						(K-KD)-pniogo	pite						
wt.% of oxi	des													
SiO ₂	42.25	45.92	42.33	43.60	46.33	42.89	42.56	39.01	42.28	40.63	44.32	44.97	45.01	39.87
Al_2O_3	9.80	10.97	11.35	9.90	10.24	12.37	12.05	10.36	11.22	11.64	10.56	10.72	9.78	10.22
MgO	24.61	27.59	25.52	25.17	27.45	28.08	27.82	23.53	27.03	26.92	27.19	27.57	27.73	24.94
BaO	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
K ₂ O	3.23	7.91	7.69	3.81	8.07	7.19	5.63	0.02	3.51	2.55	5.22	7.87	7.17	2.53
Rb ₂ O	12.20	1.14	2.55	9.38	0.20	4.36	8.19	20.48	12.70	15.04	6.59	0.02	3.09	13.27
Cs ₂ O	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
total	92.09	93.53	89.44	91.85	92.29	94.89	96.25	93.40	96.74	96.77	93.87	91.15	92.77	90.82
phlogopite of	compositio	on on the	basis of 2	22 oxygei	ns									
Si on IV	6.43	6.40	6.27	6.50	6.50	6.07	6.07	6.22	6.16	6.02	6.36	6.38	6.42	6.23
Al on IV	1.57	1.60	1.73	1.50	1.50	1.93	1.93	1.78	1.84	1.98	1.64	1.62	1.58	1.77
total IV	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00
Al on VI	0.19	0.21	0.25	0.23	0.19	0.13	0.10	0.17	0.09	0.06	0.15	0.18	0.07	0.11
Mg on VI	5.59	5.73	5.64	5.59	5.74	5.92	5.92	5.59	5.87	5.95	5.82	5.83	5.90	5.81
total VI	5.79	5.94	5.89	5.82	5.93	6.05	6.02	5.76	5.96	6.00	5.96	6.01	5.96	5.91
K on XII	0.63	1.41	1.45	0.72	1.44	1.30	1.03	0.00	0.65	0.48	0.96	1.42	1.30	0.50
Rb on XII	1.19	0.10	0.24	0.90	0.02	0.40	0.75	2.10	1.19	1.43	0.61	0.00	0.28	1.33
Cs on XII	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
Ba on XII	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
total XII	1.82	1.51	1.70	1.62	1.46	1.69	1.78	2.10	1.84	1.92	1.56	1.43	1.59	1.84
occupancy o	of XII-site	s (numbe	r of catio	ns (p.f.u)	/2), error	s are 1σ-s	standard o	leviation	of EMP	analyses				
X_{K}	0.31	0.70	0.73	0.36	0.72	0.65	0.51	0.00	0.33	0.24	0.48	0.71	0.65	0.25
ΔX_K	0.03	0.06	0.08	0.04	0.11	0.04	0.04	0.00	0.02	0.02	0.03	0.09	0.06	0.01
X_{Rh}	0.60	0.05	0.12	0.45	0.01	0.20	0.38	1.05	0.59	0.72	0.30	0.00	0.14	0.67
ΔX_{Rh}	0.07	0.01	0.00	0.05	0.00	0.01	0.01	0.03	0.03	0.02	0.09	0.00	0.02	0.00
X_{Cs}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
ΔX_{C_s}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
X _{Ba}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
ΔX_{Ba}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
X_{\Box}	0.09	0.25	0.15	0.19	0.27	0.15	0.11	0.00	0.08	0.04	0.22	0.29	0.21	0.08
ΔX_{\Box}	0.03	0.03	0.04	0.03	0.06	0.02	0.02	0.02	0.02	0.02	0.05	0.05	0.03	0.00

Table 2. Results of EMP analyses of synthesized phlogopitic micas.

up to 30 μ m (*cf.*, Fig. 1 in Melzer & Wunder, 2001). The thickness of the platelets ranges between 1 and 5 μ m.

layer polytype $2M_2$ was found in small amounts within several run products. No other polytypes were detected (Table 1).

XRD investigations

Quantitative determination of phase proportions were performed by Rietveld analyses of XRD diffractrograms. The results are compiled in Table 1 and showed that all runs yielded between 81 and 100 wt.% of phlogopitic micas. Quartz and sanidine were determined in some of the experiments from the (K-Rb)- and (K-Cs)-series. Talc as additional phase was observed in run SM63-98 of the (K-Cs)-series. The Ba-bearing phases celsian and cymrite appeared as additional phases in the runs SM83-99 and SM86-99 of the (K-Ba)-series.

The most abundant polytype in all runs is the one-layer monoclinic polytype (1*M*) except of run SM5-98, where the principle polytype is the two-layer polytype $2M_I$. Besides these two polytypes, which were detected in all runs, the two-

EMP analyses

Table 2 shows the mean values of all accepted phlogopite EMP analyses and calculated site occupancies. Formulae of phlogopitic mica were calculated on the basis of 22 oxygens per formula unit. The cation occupancies were determined in such a way that the T-sites are completely filled with Si⁴⁺ and Al³⁺, the M-sites with the Mg²⁺ cations plus the remaining Al³⁺, and the interlayers with the monovalent alkalis K⁺, Rb⁺ and Cs⁺ and, for the third series the divalent Ba²⁺.

Fig. 1a–c show the interlayer occupancies of the synthesized phlogopitic micas. Mean values for each run are taken from Table 2. As intended by the experimental approach, the produced phlogopitic micas are mainly solid solutions between phlogopite and Rb-phlogopite (Fig. 1a), phlogopite and Cs-phlogopite (Fig. 1b) and phlogopite and kinoshitali-

Table 2. (cont.)

run No.	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM
analyses	50-98 2	61-98 10	63-98 5	19-99	20-99	21-99	47-99	5-98 3	3-99	4-99	83-99 7	84-99	86-99
exp series	2	10	5		J K-Cs)-nhl	logonite	5	5	a a	ر (-Ra)-nh	/ logonite	0	0
wt % of ovid	lac			()	x cs) pin	ogopite			()	(Du) pin	ogopite		
	24 16	44.20	12 67	12 20	41.01	10.94	41.22	24.11	12 61	45 20	11 25	11 75	12 61
310_2	0 50	12.02	43.07	43.29	41.91	40.84	41.23	18.45	43.04	45.20	12.85	13/18	10.50
M_2O_3	20.11	28.30	26.70	26.52	25 55	26.41	26.24	22 52	25.01	26.20	12.05	25 44	25 32
R ₂ O	20.11	28.30	20.79	20.52	25.55	20.41	0.00	22.52	1 32	20.20	20.20	0.00	23.32
KO	0.00	8.96	6.56	0.00 8.61	8 24	0.00 7.45	0.00 8 77	0.11	7 74	9.22	2.55	9.01	2.80
R_2O	0.01	0.00	0.00	0.01	0.24	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
$C_{S}O$	26.86	1.30	5.17	1.81	2.82	4.03	1.67	0.00	0.00	0.00	0.00	0.00	0.00
total	90.73	94.88	94.92	91.48	89.50	93.44	90.43	92.13	91.64	92.90	93.89	93.67	89.21
nhlogonite c	ompositio	n on the b	asis of 22	oxygens									
Si on IV	6.21	6.17	6.20	6.27	6.26	5.89	6.06	4.24	6.22	6.36	6.23	6.26	6.35
Al on IV	1.79	1.83	1.80	1.73	1.74	2.11	1.94	3.76	1.78	1.64	1.77	1.74	1.65
total IV	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00	8.00
Al on VI	0.27	0.14	0.32	0.19	0.20	0.38	0.23	0.07	0.41	0.31	0.36	0.48	0.20
Mg on VI	5.45	5.87	5.67	5.73	5.69	5.67	5.75	5.91	5.50	5.50	5.50	5.30	5.62
total VI	5.72	6.01	5.99	5.92	5.89	6.06	5.98	5.98	5.91	5.81	5.85	5.78	5.82
K on XII	0.00	1.59	1.19	1.59	1.57	1.37	1.65	0.02	1.41	1.65	1.45	1.61	1.48
Rb on XII	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
Cs on XII	2.08	0.08	0.31	0.11	0.18	0.25	0.10	0.00	0.00	0.00	0.00	0.00	0.00
Ba on XII	0.00	0.00	0.00	0.00	0.00	0.00	0.00	1.86	0.07	0.03	0.13	0.05	0.17
total XII	2.09	1.67	1.50	1.70	1.75	1.62	1.75	1.88	1.48	1.68	1.58	1.66	1.65
occupancy o	f XII-sites	s (number	of cations	(p.f.u)/2)	, errors ar	e 1σ-stand	lard devia	tion of EN	/IP analys	es			
X_{K}	0.00	0.80	0.59	0.80	0.79	0.69	0.82	0.01	0.70	0.83	0.73	0.80	0.74
ΔX_K	0.00	0.05	0.03	0.06	0.06	0.10	0.05	0.00	0.13	0.08	0.03	0.02	0.05
X_{Rb}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
ΔX_{Rb}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.00
X_{Cs}	1.04	0.04	0.16	0.06	0.09	0.12	0.05	0.00	0.00	0.00	0.00	0.00	0.00
ΔX_{Cs}	0.02	0.00	0.03	0.00	0.02	0.01	0.00	0.00	0.00	0.00	0.00	0.00	0.00
X_{Ba}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.93	0.04	0.01	0.06	0.03	0.08
ΔX_{Ba}	0.00	0.00	0.00	0.00	0.00	0.00	0.00	0.08	0.00	0.01	0.01	0.01	0.02
X_{\Box}	-0.04	0.17	0.25	0.15	0.12	0.19	0.12	0.06	0.26	0.16	0.21	0.17	0.18
ΔX_{\Box}	0.01	0.03	0.02	0.03	0.03	0.05	0.02	0.04	0.06	0.04	0.02	0.01	0.03

te (Fig. 1c). For both, the (K-Cs)- and the (K-Ba)-series, besides Cs-phlogopite and kinoshitalite, only phlogopites close to the K-endmember have been synthesized. This does not indicate a miscibility gap and only results from the compositions of the starting bulks, which were mostly chosen to lie close to the K-endmember. Almost all phlogopites show significant concentrations of interlayer vacancies up to a maximum value of 29 mole % (Table 2, Fig. 1a-c). A positive correlation between the interlayer vacancy concentration and the Rb-content (Fig. 1a) is obvious for the (K-Rb)series. Interlayer vacancies require a charge compensation, either by the substitution of Al^{3+} by Si^{4+} at the tetrahedral sites or Mg^{2+} by Al^{3+} at the octahedral sites. In Fig. 2, the average molar fractions of Si, Mg and Al for phlogopites from each experiment are shown. All compositions, except for the Ba-endmember kinoshitalite (run SM5-98), lie within the triangle talc - phlogopite - eastonite $(KMg_{25}Al_{05}[Si_{25}Al_{15}O_{10}](OH)_2)$, shown in detail in Fig. 3. Phlogopites, for which the composition is located below the join phlogopite – celadonite (KAlMg[Si₄O₁₀](OH)₂) are solid solutions of phlogopite, eastonite and celadonite. Starting from phlogopite, variations on T- and M-sites may therefore be explained by the two exchange vectors ^{VI}Mg₁^{IV}Si₁, ^{VI}Al₁^{IV}Al₁ and ^{VI}Mg₂, ^{IV}Al₁, ^{IV}Si₁, ^{VI}Al₁, ^{VI}D₁. However, all phlogopitic micas with compositions above the join phlogopite – celadonite (grey area of Fig. 3) must have a talc component. According to the exchange vector ^{XII}K₁, ^{IV}Al₁, ^{IV}Al₁, ^{IV}Si₁, ^{IV}

IR spectroscopy

The variations of IR spectra in the spectral range 3550 to 3800 cm⁻¹ for the (K-Rb)-series are presented in Fig. 4a. All IR spectra of the (K-Rb)-series exhibit a strong OH-band, labelled the N-band after Vedder (1964), with a band maximum at about 3720 cm⁻¹ and a FWHM of about 13 cm⁻¹. Compared to pure phlogopite (3724 cm⁻¹) the N-band of the synthetic phlogopitic micas is generally shifted to lower en-



Fig. 1. Occupancy of the interlayer sites in terms of molar fractions of K, Rb, Cs, Ba, and \Box for the three experimental series as determined by EMP analyses.



Fig. 2. Mean phlogopite compositions of each sample of the three experimental series in terms of molar fractions of Si, Al, and Mg at the tetrahedral and octahedral sites plotted in a ternary diagram Mg -Al-Si. Symbols: \bigcirc (K-Rb-series), \bigcirc (K-Cs-series), \diamondsuit (K-Ba-series). Abbreviations: phl: phlogopite, eas: eastonite, cel: celadonite, tlc: talc, mus: muscovite, csh: kinoshitalite.



Fig. 3. Phlogopite compositions of each sample of the three experimental series plotted within the ternary system phlogopite – eastonite – talc. Symbols: \bigcirc (K-Rb-series), \square (K-Cs-series), \diamondsuit (K-Ba-series). Abbreviations: phl: phlogopite, eas: eastonite, cel: celadonite, tlc: talc.

ergies. A distinct shoulder on the low-energy side is visible for the samples SM37-98 and SM7-98. A strong asymmetry towards lower wavenumbers of the N-band appears in all other spectra. For fitting the band system of the N-band range, we assume up to three distinct OH-bands (Table 3). Both, the decrease of N-band wavenumbers and the existence of a fine structure of OH-stretching bands of phlogopitic micas was explained by Robert & Kodama (1988) as the result of a modification of the charge distribution around the OH-group by incorporation of Al in tetrahedral and octahedral layers. However, our EMP and IR data indicate that the shift of the N-band towards lower energies is also correlated with increasing Rb-content. For pure Rb-phlogopite (SM37-98) the N-band is located at 3718 cm⁻¹. OH-stretching bands with very low intensities but larger FWHM were observed in some of the spectra: the V-bands ($Al^{3+}Al^{3+}\Box^{VI}$) at around 3600 cm⁻¹ (cf., run SM30-99) and the I-bands $(Mg^{2+}Mg^{2+}Al^{3+})$ at about 3650 cm⁻¹ (*cf.*, run SM27-99). An additional band appears in the energy-range 3674 - 3678cm⁻¹, here termed V*-band. Comparing the results of the EMP analyses (Table 2) with the integral intensity of the V^* band, it is clear that this intensity is inversely correlated with the interlayer occupancy (Fig 4a). The V*-band is therefore interpreted as representing the talc component within the phlogopitic mica and not by chemical variations at M- and T-sites within the mica structure.

For the (K-Cs)-series, the N-band at about 3720 cm⁻¹ exhibits the highest intensity (Fig. 4b). In analogy to the (K-Rb)-series, the maximum of this band is shifted towards lower energies for increasing Cs-contents and is located at 3711 cm⁻¹ for pure Cs-phlogopite (SM56-98). The FWHM of the N-band ranges between 11 and 15 cm⁻¹ and does not show any systematic variation with increasing Cs-concentration. Broad low-intensity I- and V-bands are present in some of the spectra from the (K-Cs)-series. The V*-band at about 3676 cm⁻¹ is also present, and, in analogy to the (K-



Fig. 4a–c. IR spectra of run products of the (K-Rb)-series (a), (K-Cs)-series (b), and (K-Ba)-series (c) in the spectral region of the OH-stretching vibration. See text for explanations of the various OH-bands.

Rb)-series, its integral intensity is correlated with the amount of the EMP-determined interlayer vacancy concentrations (Table 2, Fig. 4b). For the V^{*}-band, the FWHM lies between 12 cm^{-1} and 36 cm^{-1} .

Fig. 4c shows the IR spectra determined for the (K-Ba)series. For phlogopitic mica with moderate Ba-contents (X_{Ba} < 0.1) the band with the highest intensity is located at about 3723 cm⁻¹ and is classified as the N-band. In contrast to the (K-Rb)- and (K-Cs)-series, an additional band, labelled N[#]band here, appears on the high energy side of the N-band at 3743 cm⁻¹. The intensity of the additional N[#]-band continuously increases with increasing Ba-concentration, whereas the intensity of the N-band continuously decreases. Consequently, for nearly pure kinoshitalite (SM5-98) the N-band at 3716 cm⁻¹ mostly disappeared and the main N[#]-band lies at 3747 cm⁻¹ (Fig. 4c). The FWHM of both, the N- and N[#]band are comparable and range between 8 and 36 cm⁻¹. For brittle mica endmember kinoshitalite, the local cation coordination around the hydroxyl that produces the N#-band can be ascribed to BaXII (MgMgMg)VIAIIV. Such a high-energy frequency band (3735 cm⁻¹) is also known from Ba-containing vermiculites (Fernandez et al., 1970), and was explained by Farmer (1974) as a shift of the (Mg₃OH)-frequency due

to the higher electronegativity of $Ba^{2+}(1.0)$ in comparison to Rb^+ and $Cs^+(0.9)$, which would force the hydroxyl group away from the perpendicular orientation. The N[#]-band, observed for the nearly alkali-free run SM5-98, shows a strong asymmetry to lower wavenumbers, which could only be fitted by assuming two further destinct bands (Table 3). Only for the runs SM83-99 and SM84-99 V-bands located at around 3575 cm⁻¹ and 3590 cm⁻¹ are detectable. Beside these OH-bands, only the V^{*}-band at about 3676 cm⁻¹ is present in all products. In analogy to the (K-Rb)- and (K-Cs)-series, a distinct correlation between the intensity of this band and the amount of \Box^{XII} as determined by EMP (Table 2, Fig. 4c) is obvious.

Discussion

A significant correlation between the interlayer vacancy concentrations determined by EMP (Table 2) and the intensity of the V*-band observed in the range $3674 - 3678 \text{ cm}^{-1}$ is obvious (Fig. 4a–c). The V*-band corresponds to the main OH-frequency of talc lying at 3677 cm^{-1} after Vedder (1964), which is, for comparison, shown in Fig. 4a,b. As dis-

B. Wunder, S. Melzer

run No.		SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM
		7-98	9-98	10-98	11-98	12-98	35-98	36-98	37-98	45-98	46-98	65-98	27-99	30-99	38-99
experimental series							(K	-Rb)-pł	nlogopit	e					
N-bands															
location	N_1	3702	3703	3702	3701	3703	3708	3711	3700	3711	3711		3705	3702	3701
	N_3	3710	3712	3712	3711	3713	3715	3717	3708	3716	3717	3710	3716	3714	3711
	N_3	3719	3722	3722	3720	3723	3723	3723	3718	3723	3722	3720	3723	3723	3720
integral absorbance A _N	N_1	0.45	0.42	0.39	0.30	0.39	0.24	0.34	0.52	0.19	0.40		0.15	0.10	0.13
	N_2	0.53	0.68	0.82	0.54	0.73	0.91	0.87	0.55	0.79	0.69	0.42	0.59	0.52	0.39
	N_3	1.21	1.30	1.50	1.10	1.31	1.31	1.16	1.37	1.06	0.92	1.43	0.91	1.08	0.91
	ΣN_i	2.18	2.41	2.70	1.95	2.43	2.46	2.37	2.44	2.04	2.02	1.85	1.64	1.70	1.44
FWHM	N ₁₋₃	13	14	14	13	14	14	12	13	12	11	14	14	14	12
V*-band															
location		3678	3676	3676	3676	3676	3676	3674		3675	3675	3676	3676	3678	3676
integral absorbance A _{V*}		0.20	0.41	0.36	0.37	0.41	0.45	0.11		0.09	0.05	0.30	0.59	0.23	0.10
FWHM		29	25	23	26	56	25	18		16	15	17	17	17	17
I-band															
location				3659	3656		3646			3648	3646		3641	3646	3648
integral absorbance A ₁				0.02	0.24		0.49			0.14	0.08		0.02	0.11	0.11
FWHM				14	45		60			35	35		26	44	67
V-band															
location							3594	3609		3594	3592			3598	3599
integral absorbance A _v							0.37	0.34		0.23	0.19			0.09	0.03
FWHM							47	84		50	50			18	26
calculated vacancy cond	centrat	ions on	XII												
spec. integral absorbanc	e	0.09	0.17	0.15	0.16	0.17	0.19	0.05	0.00	0.04	0.02	0.13	0.25	0.11	0.05
\hat{X}_{\Box} on XII (IR)		0.11	0.21	0.19	0.21	0.21	0.24	0.06	0.00	0.05	0.03	0.16	0.33	0.14	0.07
X_{\Box} on XII (EMP)		0.09	0.25	0.15	0.19	0.27	0.15	0.11	0.00	0.08	0.04	0.22	0.29	0.21	0.08
Deviation		0.11	-0.03	0.04	0.02	-0.05	0.09	-0.05	0.00	-0.03	-0.02	-0.05	0.04	-0.07	-0.01
ΔX_{\Box} on XII (IR)		0.04	0.04	0.04	0.04	0.04	0.04	0.04	0.05	0.04	0.04	0.04	0.05	0.05	0.05
ΔX_{\Box} on XII (EMP)		0.06	0.06	0.08	0.07	0.11	0.04	0.04	0.03	0.04	0.03	0.09	0.09	0.07	0.01

Table 3. Results of IR spectroscopic measurements and derived vacancy concentrations on the interlayer site.

 ΔX_{\Box} on XII (EMP) are 2 σ -standard deviation of the EMP analyses, ΔX_{\Box} on XII (IR) correspond to a 10% relative error of the intensity of the V*-band.

⁺ corrected for additional phases and normalized for the molar mass of phlogopite (see text)

cussed above, interlayer vacancies within phlogopitic micas require a charge compensation either by the substitution of (1) Al^{3+} by Si^{4+} at tetrahedral sites leading to a local talc configuration, or (2) Mg²⁺ by Al³⁺ at the octahedral sites. Indeed, according to Robert & Kodama (1988), OH-bands lying between 3650 and 3675 cm⁻¹ should be attributed to some Al on octahedral sites. If substitution (2) is relevant, a correlation of the intensity of the V*-band and I-band should exist. This is, however, not the case (Table 3). Additionally, the amount of octahedral Al in the synthesized phlogopitic micas is extremely low (Table 2) and shows no correlation with the intensity of the V*-band. We therefore assume that the V*-band exhibits information about the vacancy concentration on the twelve-fold position representing the talc component of phlogopitic micas and that (1) (Al^{3+} by Si^{4+} at tetrahedral sites) is the relevant substitution mechanism. The local coordination around hydroxyl that produces the V^{*}-band is therefore $\Box^{XII}(MgMgMg)^{VI}Si^{IV}$.

Based on these considerations, the integral intensity of the V^{*}-band A_V^* was determined for both, synthetic phlogopitic micas of the three experimental series (Table 3) and synthetic talc of the endmember composition $Mg_3Si_4O_{10}(OH)_2$, previously synthesized as a single phase and characterized by Wunder *et al.* (1997). The weighted portion of the run products were corrected for additional phases and normalized to the molar mass of phlogopitic mica. This resulted in specific integral intensities (Table 3). The coefficient of the normalized band intensities of phlogopitic micas and talc represents the IR-determined interlayer vacancy concentration ($^{IR}X_{\Box}^{XII}$) of phlogopitic micas. The dependence of the linear absorption coefficient as a function of the wavenumber (Libowitzky & Rossman, 1997) was not considered, because the structural similar materials talc and phlogopite absorb IR radiation in the same frequency range. The procedure resulting in the concentration of $^{IR}X_{\Box}^{XII}$ is expressed by:

$${}^{IR}X_{\Box} X_{II} = \frac{A_V * (3674 - 3678 \text{ cm}^{-1}, \text{mica}) / [\text{wt.}\%(\text{mica, Rietveld})/(M(\text{mica}) \cdot 1000)]}{A_V * (3676 \text{ cm}^{-1}, \text{talc}) / [1/M(\text{talc}) \cdot 10]} (1)$$

The derived ${}^{IR}X_{\Box}{}^{XII}$ concentations are listed in Table 3 and are plotted against the vacancy concentration (${}^{EMP}X_{\Box}{}^{XII}$) as determined by EMP in Fig. 5. Most of calculated vacancy concentrations ${}^{IR}X_{\Box}{}^{XII}$ are, within the assumed uncertain-

Table 3. (cont.)

run No.	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM	SM
	56-98	61-98	63-98	19-99	20-99	21-99	47-99	5-98	3-99	4-99	83-99	84-99	86-99
experimental series		(1	X-Cs)-ph	llogopit	9				(K	ва)-pł	llogopite	9	
N-bands													
location N	1 3694	3708	3703	3701		3703	3702		3702	3702	3700	3697	3702
Ν	₂ 3703	3716	3712	3711	3710	3713	3712		3712	3712	3713	3711	3711
N	₃ 3711	3724	3719	3721	3721	3721	3722	3716	3723	3723	3723	3722	3724
integral absorbance A _N N	0.45	0.26	0.19	0.32		0.41	0.33		0.26	0.26	0.07	0.12	0.12
N	₂ 0.53	0.91	0.63	0.65	0.46	1.28	0.76		0.59	0.65	0.39	0.39	0.24
N	3 I.I3	1.16	0.81	1.18	1.40	2.17	1.26	0.37	0.97	1.10	0.80	0.77	0.48
ΣN	_i 2.11	2.32	1.62	2.15	1.87	3.86	2.35	0.37	1.82	2.01	1.26	1.29	0.84
FWHM N ₁	3 11	13	14	14	15	13	13	36	15	14	16	17	17
N [#] -bands													
location $N_1^{\#} N$	1							3734	3744	3742	3743	3742	3744
Ν	# 2							3741					
Ν	# 3							3747					
integral absorbance A _N # N	# 1							0.13	0.18	0.12	0.13	0.17	0.23
N	# 2							0.35					
N	# 3							1.00	0.40			o 1 -	
ΣN FWHM N [#]	ĭ							1.48	0.18	0.12	0.12	0.17	0.23
V* band	3							0	10	11	10		10
location	3677	3677	3678	3678	3676	3675	3674	3673	3675	3677	3677	3678	3674
integral absorbance A	0.07	0.30	0.57	0.47	0.05	0.43	0.25	0.20	0.45	0.37	0.49	0.43	038
FWHM	13	24	25	31	12	10	36	19	28	25	28	0. 4 5 27	25
I-bands	15	21	25	51	12	17	50	17	20	23	20	27	
location		3650	3652						3630		3651	3652	
integral absorbance A ₁		0.44	0.34						0.08		0.51	0.64	
FWHM		76	42						25		83	57	
V-bands													
location		3590	3600						3604		3575	3590	3561
integral absorbance A _v		0.36	0.32						0.18		1.43	1.26	0.09
FWHM		46	45						38		64	57	42
calculated vacancy concent	ations on	XII											
spec. integral absorb. $A_{V^{*+}}^+$	0.04	0.12	0.24	0.25	0.02	0.09	0.11	0.10	0.19	0.15	0.22	0.18	0.17
X_{\Box} on XII (IR)	0.05	0.16	0.31	0.19	0.03	0.12	0.14	0.13	0.24	0.19	0.29	0.23	0.22
X_{\Box} on XII (EMP)	-0.04	0.17	0.25	0.15	0.12	0.19	0.12	0.06	0.26	0.16	0.21	0.17	0.18
deviation	0.09	-0.01	0.06	0.04	-0.09	-0.07	0.02	0.07	0.02	0.03	0.08	0.05	0.04
ΔX_{\Box} on XII (IR)	0.05	0.04	0.04	0.04	0.04	0.04	0.04	0.05	0.04	0.04	0.05	0.04	0.05
ΔX_{\Box} on XII (EMP)	0.02	0.05	0.04	0.06	0.06	0.10	0.05	0.08	0.13	0.08	0.03	0.02	0.06

⁺ corrected for additional phases and normalized for the molar mass of phlogopite (see text)

ties, in agreement to the ^{EMP}X_□^{XII} concentations. However, for a reliable spectroscopically quantification of interlayer vacancy concentrations, uncertainties are too high. The scattering shown in Fig. 5 has different reasons: *e.g.* it might be due to variations in the local structure of the micas, for which varying absorption coefficients have to be expected. Other problems might be the determination of the integrated intensities from the KBr-pellets, in which the platy crystals might be oriented during pressurization, or even inhomogeneity of the powder distribution within the pellets. Nevertheless, it is clear that IR spectroscopy is an appropriate method for identification of interlayer vacancies within phlogopitic micas.

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Fig. 5. Vacancy concentrations determined by EMP ($^{EMP}X_{\Box}^{XII}$) *versus* vacancy concentrations determined by IR ($^{IR}X_{\Box}^{XII}$). For explanation of the error bars see Table 3.

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